CD4011A, CD4012A, CD4023A Types

TEXAS INSTRUMENTS Data sheet acquired from Harris Semiconductor

CMOS NAND Gates

Quad 2 Input — CD4011A Dual 4 Input — CD4012A Triple 3 Input — CD4023A

The TI-CD4011A, CD4012A, and CD-4023A NAND gates provide the system designer with direct implementation of the NAND function and supplement the existing family of CMOS gates.

These types are supplied in 14-lead hermetic dual-in-line ceramic packages (D and F suffixes), 14-lead dual-in-line plastic packages (E suffix), 14-lead ceramic flat packages (K suffix), and in chip form (H suffix).

Features:

- Quiescent current specified to 15 V
- Maximum input leakage of 1 μA at 15 V (full package-temperature range)
- 1-V noise margin (full package-temperature range)

RECOMMENDED OPERATING CONDITIONS

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

| Characteristic | Min. | Max. | Units |
|--|------|------|-------|
| Supply Voltage Range (over full package temperature range) | 3 | 12 | ٧ |

MAXIMUM RATINGS, Absolute-Maximum Values:

| STORAGE-TEMPERATURE RANGE (Tstg) |
|---|
| OPERATING-TEMPERATURE RANGE (TA): |
| PACKAGE TYPES D, F, K, H |
| PACKAGE TYPE E40 to +85°C |
| DC SUPPLY-VOLTAGE RANGE, (VDD) |
| (Voltages referenced to VSS Terminal): |
| POWER DISSIPATION PER PACKAGE (PD): |
| FOR T _A = -40 to +60°C (PACKAGE TYPE E) |
| FOR T _A = +60 to +85°C (PACKAGE TYPE E)Derate Linearly at 12 mW/°C to 200 mW |
| FOR T _A = -55 to +100°C (PACKAGE TYPES D, F, K) |
| FOR TA = +100 to +125°C (PACKAGE TYPES D, F, K) Derate Linearly at 12 mW/°C to 200 mW |
| DEVICE DISSIPATION PER OUTPUT TRANSISTOR |
| FOR TA = FULL PACKAGE-TEMPERATURE RANGE (ALL PACKAGE TYPES)100 mW |
| INPUT VOLTAGE RANGE, ALL INPUTS |
| LEAD TEMPERATURE (DURING SOLDERING): |
| At distance 1/16 \pm 1/32 inch (1.59 \pm 0.79 mm) from case for 10 s max |

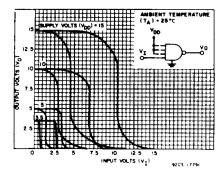


Fig. 2 — Minimum & maximum voltage transfer characteristics.

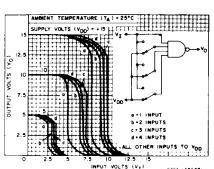


Fig. 4 — Typical multiple input switching transfer characteristics for CD4012A.

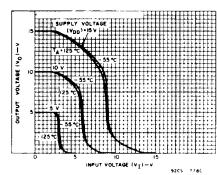


Fig. 3 — Typical voltage transfer characteristics as a function of temperature.

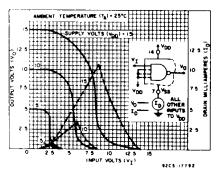
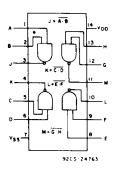
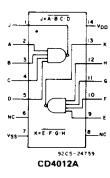


Fig. 5 — Typical current & voltage transfer characteristics.



CD4011A



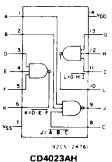
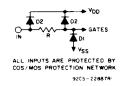


Fig. 1 - Functional diagrams.



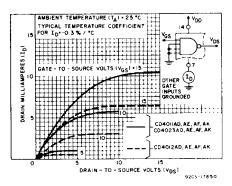


Fig. 6 - Typical n-channel drain characteristics.

CD4011A, CD4012A, CD4023A Types

STATIC ELECTRICAL CHARACTERISTICS

| | Conditions | | | Limits at Indicated Temperatures (°C) | | | | | | | | |
|--|------------|-------------|-----|---------------------------------------|----------------------|-------|-----------|-------------|---------------|-------|-------------|----------|
| Characteristic | | | | D,F,K,H Packages | | | E Package | | | | Units | |
| Characteristic | ٧o | VIN VDD | | -55 + | | +125 | | -40 | +25 | | +85 | |
| | (V) | (V) | (V) | | Тур. | Limit | | | - | Limit | | |
| Quiescent Device | | _ | 5 | 0.05 | 0.001 | 0.05 | 3 | 0.5 | 0.005 | 0.5 | 15 | |
| Current, I Max. | | _ | 10 | 0.1 | 0.001 | 0.1 | 6 | 5 | 0.005 | 5 | 30 | μΑ |
| | | | 15 | 2 | 0.02 | 2 | 40 | 50 | 0.5 | 50 | 500 | |
| Output Voltage: Low-Level | | 0,5 | 5 | <u> </u> | 0 Typ.; 0.05 Max. | | | | | | | |
| VOL | | 0,10 | 10 | L | | | Typ.; | 0.05 Ma | x. | | | V |
| High Level, | _ | 0,5 | 5 | | | | 1.95 Mir | <u> </u> | <u> </u> | | | |
| Voн | _ | 0,10 | 10 | | | | 9.95 Mii | 1.; 10 T | yp. | | | |
| Noise Immunity: Inputs Low, | 3.6 | <u> </u> | 5 | | 1.5 Min.; 2.25 Typ. | | | | | | | |
| VNL | 7.2 | - | 10 | İ | 3 Min.; 4.5 Typ. | | | | | | | |
| Inputs High, | 1.4 | Ī- | 5 | | 1.5 Min.; 2.25 Typ.; | | | | | | | |
| VNH | 2.8 | - | 10 | | 3 Min.; 4.5 Typ. | | | | | | | |
| Noise Margin: Inputs Low, | 4.5 | _ | 5 | 1 Min. | | | | | | | | |
| VNML | 9 | - | 10 | 1 Min. | | | | | | | | v |
| Inputs High, | 0.5 | | 5 | 1 | | | 1 | Min. | " | | |] |
| VNMH | 1 | <u> </u> | 10 | 1 | | | 1 | Min. | | | | <u> </u> |
| Output Drive Current: N-Channel (Sink) IDN Min. CD4011A | 0.5 | _ | 5 | 0.31 | 0.5 | 0.25 | 0.175 | 0.145 | 0.5 | 0.12 | 0.095 | |
| CD4011A | 0.5 | † | 10 | 0.62 | 0.6 | 0.5 | 0.35 | 0.3 | 0.6 | 0.25 | 0.2 | 1 |
| | 0.5 | ┼- | 10 | 0.62 | | 0.5 | | | | | | 1 |
| CD4012A | 0.5 | | 5 | 0.15 | 0.25 | 0.12 | 0.085 | 0.072 | 0.25 | 0.06 | 0.05 | mA |
| CD4012A | 0.5 | - | 10 | 0.31 | 0.6 | 0.25 | 0.175 | 0.155 | 0.6 | 0.13 | 0.105 | |
| P-Channel (Source), | 4.5 | - | 5 | -0.31 | -0.5 | -0.25 | -0.175 | -0.145 | -0.5 | -0.12 | -0.095 | |
| IDP Min. All Types | 9.5 | T- | 10 | -0.75 | ∙1.2 | -0.6 | -0.4 | -0.35 | -1.2 | -0.3 | -0.24 | |
| Input Leakage Current, | | iny iput | 15 | ±10 ⁻⁵ Typ.; ±1 Max. | | | | | | | μА | |

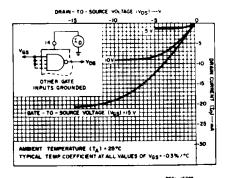


Fig. 7 — Typical p-channel drain characteristics.

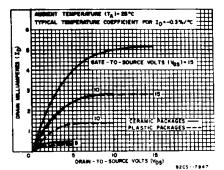


Fig. 8 — Minimum n-channel drain characteristics —CD4011A & CD4023A.

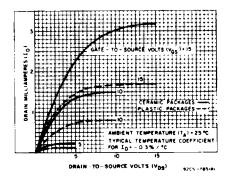


Fig. 9 — Minimum n-channel drain characteristics.

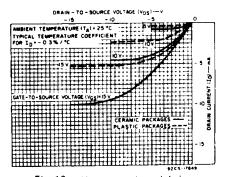


Fig. 10 — Minimum p-channel drain characteristics.

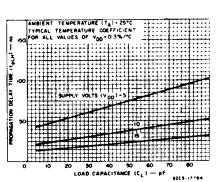


Fig. 11 — Typical low-to-high level propagation delay time vs. C_L .

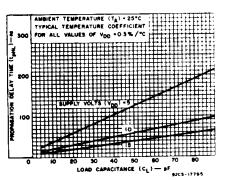


Fig. 12 -- Typical high-to-low level propagation delay time vs. C_L - CD4011A, & CD4023A.

CD4011A, CD4012A, CD4023A Types

DYNAMIC ELECTRICAL CHARACTERISTICS at T_A = 25°C, C_L = 15 pF, Input t_r , t_f = 20 ns, R_L = 200 K Ω

| | TES | | | | | | | |
|--|--------|------------------------|------|------------------------|------|--------------|-------|--|
| CHARACTERISTICS | CONDIT | CONDITIONS | | D, F, K, H Packages | | E Package | | |
| | | V _{DD} (V) | Тур. | Max. | Тур. | Max. | | |
| Propagation Delay Time: Low-to-High Level, tp _{LH} | | 5 | 50 | 75 | 50 | 100 | ns | |
| | | 10 | 25 | 40 | 25 | 50 | ''3 | |
| High-to-Low Level, tPHL CD4011A and CD4023A | | 5 | 50 | 75 | 50 | 100 | ns | |
| | | 10 | 25 | 40 | 25 | 50 | | |
| CD4012A | | 5 | 100 | 150 | 100 | 200 | 2n | |
| | | 10 | 50 | 75 | 50 | 100 | 1 ''' | |
| Transition Time: | | 5 | 75 | 100 | 75 | 125 | ns | |
| Low-to-High Level, tTLH | | 10 | 40 | 60 | 40 | 75 | 1 115 | |
| High-to-Low Level, t _{THL} CD4011A and CD4023A | | 5 | 75 | 125 | 75 | 150 | ns | |
| | | 10 | 50 | 75 | 50 | 100 | 1 " | |
| CD4012A | | 5 | 250 | 375 | 250 | 500 | ns | |
| | | 10 | 125 | 200 | 125 | 250 | | |
| Input Capacitance, C ₁ | Any In | put | 5 | _ | 5 | _ | pF | |

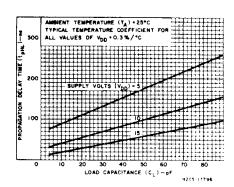


Fig. 13 — Typical high-to-low level propagation delay time vs. C_L — CD4012A.

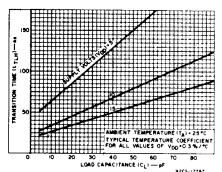


Fig. 14 — Typical low-to-high transition time vs. C_L .

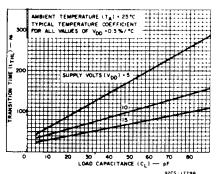


Fig. 15 — Typical high-to-low level transition time vs. C_L — CD4011A & CD4023A.

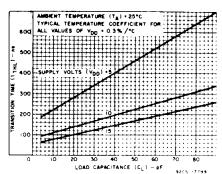


Fig. $16 - Typical high-to-low level transition time vs. <math>C_L - CD4012A$.

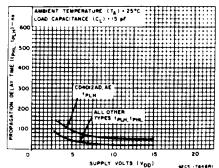


Fig. 17 — Minimum propagation delay time vs. VDD.

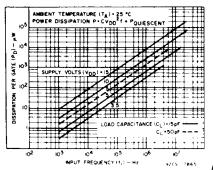


Fig. 18 — Typical dissipation characteristics.

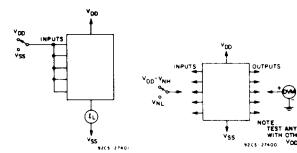


Fig. 19 — Quiescent device current test circuit.

Fig. 20 - Noise immunity test circuit.

Fig. 21 - Input leakage current test circuit.

MEASURE INPUTS
SEQUENTIALLY,
TO BOTH VOD AND VSS
CONNECT ALL UNUSED
INPUTS TO EITHER

V_{DO} OR V_{SS}

IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third—party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Mailing Address:

Texas Instruments Post Office Box 655303 Dallas, Texas 75265

Copyright © 2002, Texas Instruments Incorporated